Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/763,194	FUJIKAWA ET AL.	
Examiner	Art Unit	
M. Alexandra Elve	1725	

SEARCHED					
Class	Subclass	Date	Examiner		
219	69.11	6/28/2007	MAE		
219	69.12	6/28/2007	MAE		
219	69.15	6/28/2007	MAE		
219	69.17	6/28/2007	MAE		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
US OCR, US PAT, US PG, Derwent, JPO, EPO	6/28/2007	MAE		